

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/709,503	DENQ ET AL.		
Examiner	Art Unit		
Jeff Piziali	2629		

SEARCHED				
Class	Subclass	Date	Examiner	
345	156- 159,162,1 68,169,17 3-180	6/22/2007	J.P.	
345	182-184	6/22/2007	J.P.	
178	18.01	6/22/2007	J.P.	
178	18.03	6/22/2007	J.P.	
178	18.05	6/22/2007	J.P.	
178	18.06	6/22/2007	J.P.	
178	18.07	6/22/2007	J.P.	
178	18.08	6/22/2007	J.P.	
178	19.01	6/22/2007	J.P.	
178	19.03	6/22/2007	J.P.	
178	19.04	6/22/2007	J.P.	
178	20.01	6/22/2007	J.P.	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

(INCLUDING SE	ARCH STRATEG	Y)
	DATE	EXMR
EAST Search	6/22/2007	J.P.